


Search Notes 	Application/Control No. 10540501	Applicant(s)/Patent Under Reexamination HAMEAU ET AL.
	Examiner Chen, Shin-Hon	Art Unit 2131

SEARCHED			
Class	Subclass	Date	Examiner
713	190,193,194,300, 322	1/4/08	S.C.

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	1/4/08	S.C.
NPL search (google)	1/4/08	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner